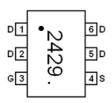


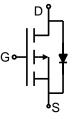
SSF2429UP

Main Product Characteristics:

| V _{DSS} | -20V |
|----------------------|---------------------|
| R _{DS} (on) | 29 m Ω(typ.) |
| Ι _D | -5A |







SOT23-6

Marking and Pin Assignment



Features and Benefits:

- Advanced trench MOSFET process technology
- Special designed for PWM, load switching and general purpose applications
- Ultra low on-resistance with low gate charge
- Fast switching and reverse body recovery
- 150°C operating temperature



Description:

It utilizes the latest trench processing techniques to achieve the high cell density and reduces the on-resistance with high repetitive avalanche rating. These features combine to make this design an extremely efficient and reliable device for use in power switching application and a wide variety of other applications

Absolute Max Rating:

| Symbol | Symbol Parameter | | | | |
|--|--|------|---|--|--|
| I _D @ TC = 25°C | Continuous Drain Current, V _{GS} @ 10V① | -5 | Α | | |
| I _{DM} | DM Pulsed Drain Current② | | | | |
| P _D @TC = 25°C | Power Dissipation3 | 1.4 | W | | |
| V _{DS} | -20 | V | | | |
| V _{GS} Gate-to-Source Voltage | | ± 12 | V | | |
| T _J T _{STG} | -55 to +150 | °C | | | |

Thermal Resistance

| Symbol | Characterizes | Тур. | Max. | Units |
|------------------|--|------|------|-------|
| R _{θJA} | Junction-to-ambient (t $\leq 10s)$ (4) | | 90 | °C/W |



Electrical Characterizes@T_A=25°Cunless otherwise specified

| Symbol | Parameter | Min. | Тур. | Max. | Units | Conditions |
|---------------------|--------------------------------------|------|------|------|-------|---|
| $V_{(BR)DSS}$ | Drain-to-Source breakdown voltage | -20 | _ | | V | $V_{GS} = 0V, ID = -250\mu A$ |
| R _{DS(on)} | Static Drain-to-Source on-resistance | _ | 29 | 35 | mΩ | V_{GS} =-4.5V,I _D = -5A |
| | | _ | 36 | 48 | | V_{GS} =-2.5V,I _D = -3A |
| V _{GS(th)} | Gate threshold voltage | -0.5 | _ | -1 | V | $V_{DS} = V_{GS}, I_D = -250 \mu A$ |
| I _{DSS} | Drain-to-Source leakage current | _ | _ | -1 | μA | $V_{DS} = -20V, V_{GS} = 0V$ |
| | Cata to Source ferward lookage | _ | _ | 100 | 24 | V _{GS} =12V |
| I _{GSS} | Gate-to-Source forward leakage | _ | _ | -100 | nA | V _{GS} = -12V |
| Qg | Total gate charge | _ | 12 | _ | | V _{DS} =-10V, |
| Q_{gs} | Gate-to-Source charge | _ | 1.3 | _ | nC | I _D =-4.5A, V _{GS} =-5V |
| Q _{gd} | Gate-to-Drain("Miller") charge | _ | 3.5 | _ | | |
| t _{d(on)} | Turn-on delay time | _ | 11 | _ | | |
| tr | Rise time | _ | 10 | _ | | V_{DD} =-10V,R _L =2.5 Ω V_{GS} =-4.5V,R _{GEN} =3 Ω |
| t _{d(off)} | Turn-Off delay time | _ | 17 | _ | ns | |
| t _f | Fall time | _ | 22 | _ | | |
| C _{iss} | Input capacitance | _ | 874 | _ | | $V_{GS} = 0V$ |
| C _{oss} | Output capacitance | _ | 99 | | pF | $V_{DS} = -20V$ |
| C _{rss} | Reverse transfer capacitance | _ | 86 | _ | | <i>f</i> = 1.0MHz |

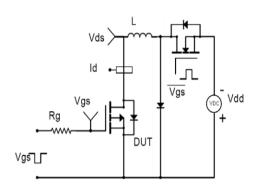
Source-Drain Ratings and Characteristics

| Symbol | Parameter | Min. | Тур. | Max. | Units | Conditions | |
|-----------------|---|------|------|------|-------|---|--|
| Is | Continuous Source Current (Body Diode) | | _ | -5 | A | MOSFET symbol [□] , showing the _G → ⊣ + | |
| I _{SM} | Pulsed Source Current (Body Diode) | _ | _ | -20 | A | integral reverse H | |
| V _{SD} | Diode Forward Voltage | _ | -0.8 | -1.3 | V | I _S =-1.3A, V _{GS} =0V | |

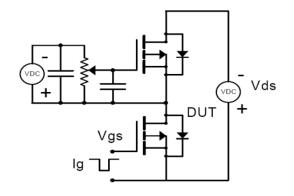


Test Circuits and Waveforms

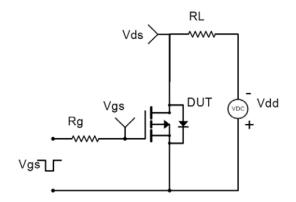
EAS Test Circuit:



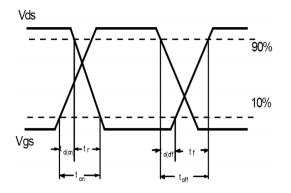
Gate Charge Test Circuit:



Switching Time Test Circuit:



Switching Waveforms:



Notes:

- ①The maximum current rating is limited by bond-wires.
- 2 Repetitive rating; pulse width limited by max. junction temperature.
- ③The power dissipation PD is based on max. junction temperature, using junction-to-case thermal resistance.
- (4) The value of $R_{\theta JA}$ is measured with the device mounted on 1in 2 FR-4 board with 2oz. Copper, in a still air environment with TA =25°C



SSF2429UP

Typical Electrical and Thermal Characteristics

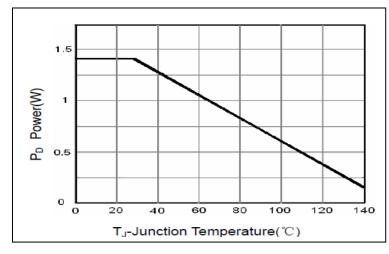
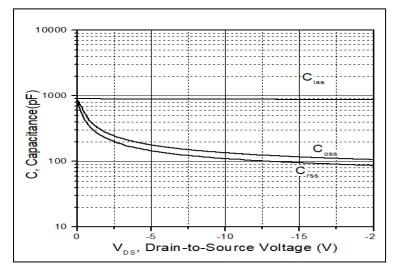


Figure 1. Power Dissipation





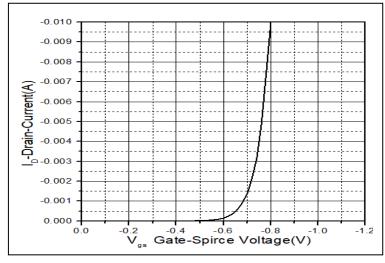


Figure5.Transfer Characteristics

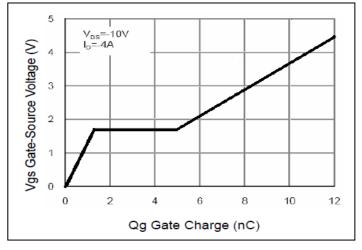


Figure 2. Gate Charge

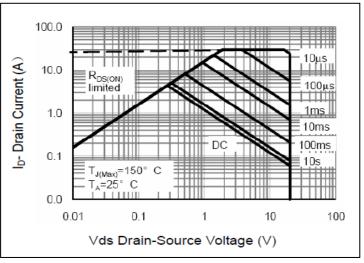
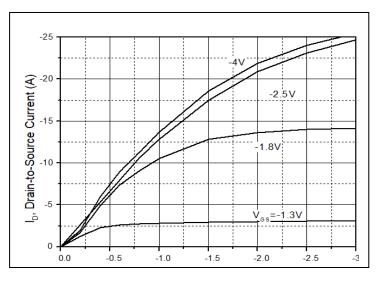


Figure 4. Safe Operation Area

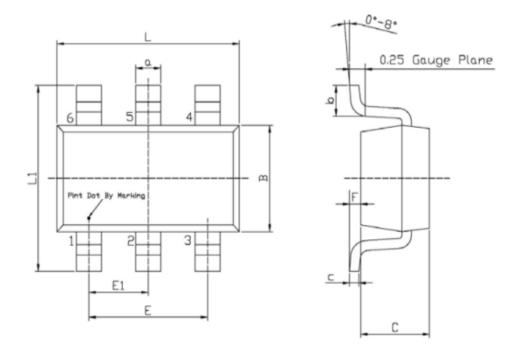






Mechanical Data:

SOT-23-6L PACKAGE OUTLINE DIMENSION



Unit: mm

| Symbol | Dimensions In Millimeters | | Cumbral | Dimensions In Millimeters | | |
|--------|---------------------------|------|---------|---------------------------|------|--|
| | Min | Max | Symbol | Min | Max | |
| L | 2.82 | 3.02 | E1 | 0.85 | 1.05 | |
| В | 1.50 | 1.70 | ۵ | 0.35 | 0.50 | |
| С | 0.90 | 1.30 | С | 0.10 | 0.20 | |
| L1 | 2.60 | 3.00 | b | 0.35 | 0.55 | |
| Ε | 1.80 | 2.00 | F | 0 | 0.15 | |



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